

# 40V N-Channel Trench MOSFET(Preliminary)

General Description			Product Summary		
<ul> <li>Trench Power technology</li> <li>Low R<sub>DS(ON)</sub></li> <li>Low Gate Charge</li> <li>Optimized for fast-switching applications</li> </ul>			$V_{DS}$ $I_{D} (at V_{GS} = 10V)$ $R_{DS(ON)} (at V_{GS} = 10V)$ $R_{DS(ON)} (at V_{GS} = 4.5V)$	40V 20A <23mΩ <28mΩ	
<ul> <li>Applications</li> <li>Synchronous Rectification in DC/DC and AC/DC Converters</li> <li>Isolated DC/DC Converters in Telecom and Industrial</li> </ul>			100% UIS Tested	RoHS	
	TO-252 G D S	D			
Part Number	Packa	де Туре	Form	Marking	
TTD20N04AT	то	-252	Tape&Reel	TTD20N04AT	
Absolute Maximum Ra	tings (T -2				
Parameter		Symbol	therwise noted) Maximum	Units	
Parameter		1		Units V	
Parameter Drain-Source Voltage	ungs (1 <sub>A</sub> –23	Symbol	Maximum		
Parameter Drain-Source Voltage Gate-Source Voltage	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V <sub>DS</sub>	Maximum 40	V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>B</sup>	T <sub>c</sub> =25°C	Symbol V <sub>DS</sub> V <sub>GS</sub>	Maximum           40           ±20           20	V V	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current	T <sub>c</sub> =25°C	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub>	Maximum           40           ±20           20           17	V V A	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current         Avalanche Current	T <sub>c</sub> =25°C	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub>	Maximum           40           ±20           20           17           60	V V A A	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current         Avalanche Current         A         Single Pulse Avalanche Energy	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AS</sub> E <sub>AS</sub>	Maximum           40           ±20           20           17           60           13	V V A A A A	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current         Avalanche Current         A         Single Pulse Avalanche Energy	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ L = 0.3mH <sup>A</sup>	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AS</sub>	Maximum       40       ±20       20       17       60       13       25	V V A A A M mJ	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current         Avalanche Current         A         Single Pulse Avalanche Energy         Power Dissipation         C	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AS</sub> E <sub>AS</sub>	Maximum         40         ±20         20         17         60         13         25         28.8	V V A A A M M W	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current         Avalanche Current         A         Single Pulse Avalanche Energy         Power Dissipation         C         Junction and Storage Temperatu	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AS</sub> E <sub>AS</sub> P <sub>D</sub>	Maximum         40         ±20         20         17         60         13         25         28.8         14.4	V V A A A M M W W	
Parameter Drain-Source Voltage Gate-Source Voltage	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AS</sub> E <sub>AS</sub> P <sub>D</sub>	Maximum         40         ±20         20         17         60         13         25         28.8         14.4	V V A A A M M W W	
Parameter         Drain-Source Voltage         Gate-Source Voltage         Continuous Drain Current         B         Pulsed Drain Current         Avalanche Current         A         Single Pulse Avalanche Energy         Power Dissipation         C         Junction and Storage Temperatu         Thermal Characteristics	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AS</sub> E <sub>AS</sub> P <sub>D</sub> T <sub>J</sub> , T <sub>STG</sub>	Maximum         40         ±20         20         17         60         13         25         28.8         14.4         -55 to 175	V V A A A M A M W W W W	



Electric	cal Characteristics(T <sub>J</sub> =25°C ur	less otherwise r	noted)				
Sumbel Decemptor	Deremeter	Conditions		Value			
Symbol	Parameter			Min	Тур	Max	- Units
STATIC P	ARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	I <sub>D</sub> =250µA,V <sub>GS</sub> =0V		40			V
I <sub>DSS</sub> Zero Gate Voltage Drain Current		V <sub>DS</sub> =40V, V <sub>GS</sub> =0V	T <sub>J</sub> =25°C			1	- μΑ
	Zero Gate Voltage Drain Current		T <sub>J</sub> =125°C			100	
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$	1			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA		1	1.4	2	V
		V <sub>GS</sub> =10V, I <sub>D</sub> =20A			18	23	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =16A			21.5	28	mΩ
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A			19		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =20A, V <sub>GS</sub> =0V				1	V
l <sub>s</sub>	Maximum Body-Diode Continuous Curre	rent <sup>B</sup>				20	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f =1MH <sub>Z</sub>			659		pF
C <sub>oss</sub>	Output Capacitance				70		
C <sub>rss</sub>	Reverse Transfer Capacitance				62		
R <sub>g</sub>	Gate Resistance	f =1MH <sub>z</sub>			1.2		Ω
SWITCHIN	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge				16.7		
Q <sub>g</sub> (4.5V)	Total Gate Charge			9		nC	
Q <sub>gs</sub>	Gate Source Charge	V <sub>GS</sub> =10V,V <sub>DS</sub> =20V, I <sub>D</sub> =20A			1.9		
$Q_{gd}$	Gate Drain Charge				4.5		
t <sub>D(on)</sub>	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 20V, I_{D} = 20A,$ $R_{G} = 1.8\Omega$			31		
t <sub>r</sub>	Turn-On Rise Time				3.6		ns
T <sub>D(off)</sub>	Turn-Off Delay Time				46		
t <sub>f</sub>	Turn-Off Fall Time				2.8		
t <sub>rr</sub>	Body Diode Reverse Recovery Time		16		18.3		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	—I <sub>F</sub> =20A, di/dt =100A/μs			4		nC

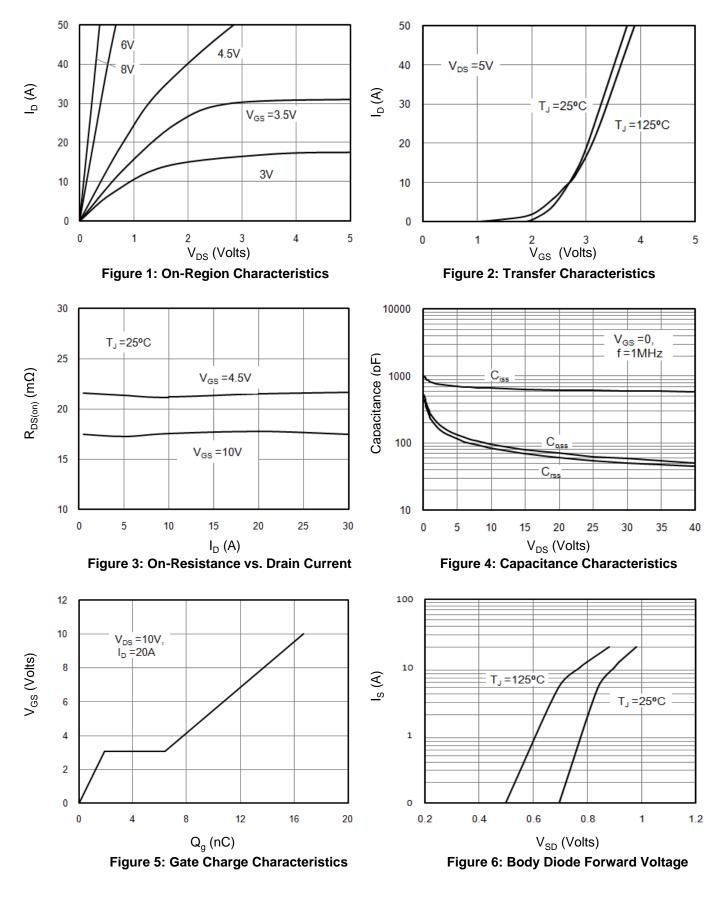
A. Single pulse width limited by maximum junction temperature.

B. The maximum current rating is package limited.

C. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

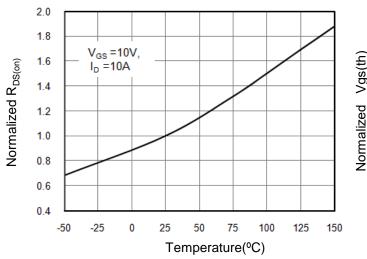


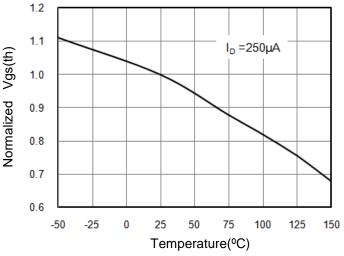
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

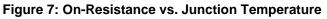


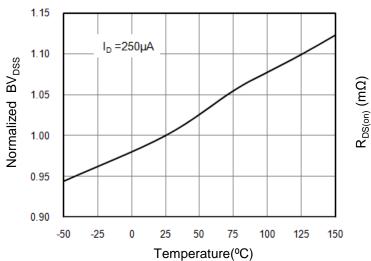


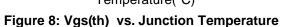
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS











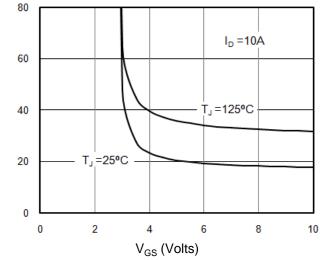


Figure 9: BV<sub>DSS</sub> vs. Junction Temperature Figure 10: On-Resi

D =0.5 D =0.2

D =0.1

D =0.05

D =0.02

D =0.01

0.1

Single Pulse

Figure 10: On-Resistance vs. Gate-Source Voltage

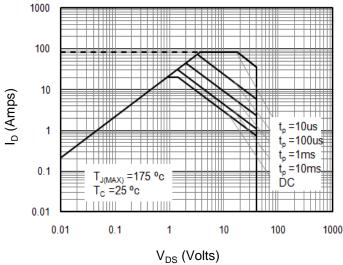


Figure 11: Normalized Transient Thermal Resistance

0.01

Figure 12: Safe Operating Area

 $Z_{\,\Theta\,JC}$  Normalized Transient Thermal Resistance

10

1

0.1

0.01

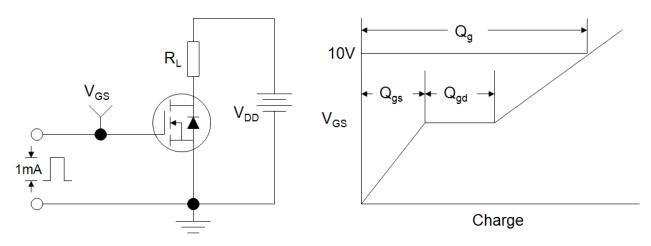
0.0001

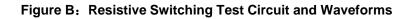
0.001

Pulse Width (s)

1







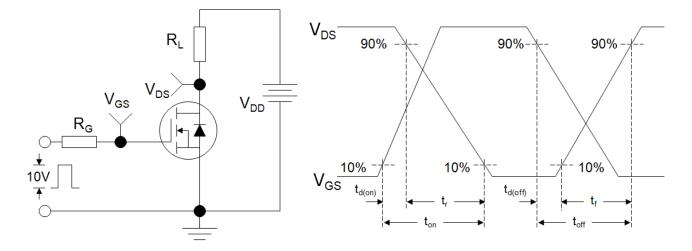
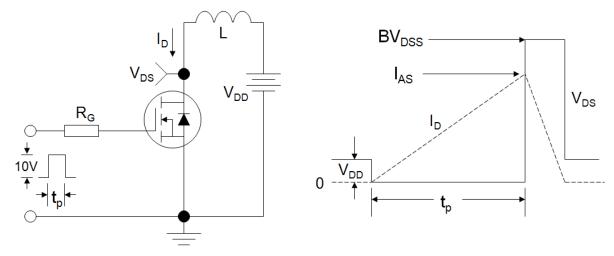
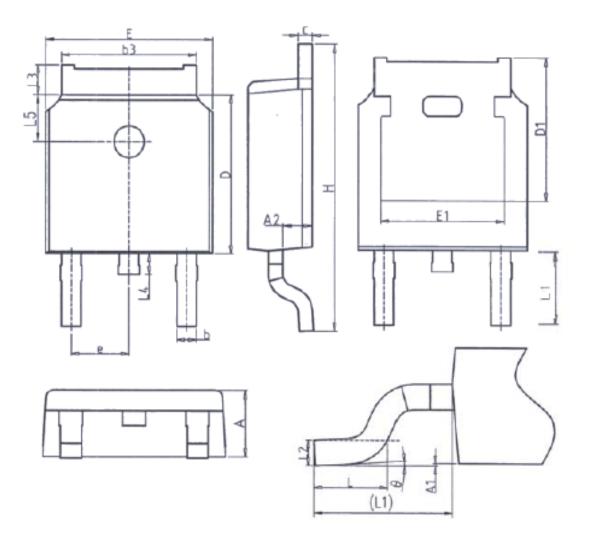


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





TO-252(集佳)



Unit: mm				
Symbol	Min	Nom	Max	
Α	2.20	2.30	2.38	
A1	0.00	-	0.10	
A2	0.90	1.01	1.10	
b	0.72	-	0.85	
b3	5.13	5.33	5.46	
С	0.47	-	0.60	
D	6.00	6.10	6.20	
D1	5.25 REF			
E	6.50	6.60	6.70	
E1	4.70	-	-	

Unit: mm					
Symbol	Min	Nom	Max		
e	2.286BSC				
Н	9.80	10.10	10.40		
L	1.40	1.50	1.70		
L1	2.90REF				
L2	0.508BSC				
L3	0.90	-	1.25		
L4	0.60	0.80	1.00		
L5	1.8 REF				
θ	0° - 8°				



## Disclaimer

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